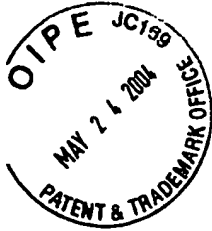


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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(use as many sheets as necessary)</i>		Complete If Known	
		Application Number	09/731,481
		Filing Date	12-06-2000 MAY 28 2004
		First Named Inventor	Liu
		Group Art Unit	2623 Technology Center 2600
		Examiner Name	Bhatnagar, A.
Sheet	2	of	3
		Attorney Docket Number	MS1-684US

NON PATENT LITERATURE DOCUMENTS			
Examiner Initials <sup>1</sup>	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
AB		PEI et al., "Global Motion Estimation in Model-Based Image Coding by Tracking Three-Dimensional Contour Feature Points", IEEE, 1051-8215/98, 1998, pages 181-190.	
AB		PIGHIN et al., "Resynthesizing Facial Animation Through 3-D Model-Based Tracking", IEEE, Inspec Accession Number 6371194, 1999, pages 1-8.	
AB		SHAKUNAGA et al., "Integration of Eigentemplate and Structure Matching for Automatic Facial Feature Detection", IEEE, Inspec Accession Number 5920393, pages 1-6.	
AB		PERLIN, "Realtime Responsive Animation with Personality", IEEE, 1071-2626/95, pages 5-15.	
AB		SKARIA et al., "Modeling Subdivision Control Meshes for Creating Cartoon Faces", IEEE 0-7695-0853-7/01, 2001, pages 216-225.	
AB		PARKE, "Computer Graphic Models for the Human Face", IEEE, CH515-6/79/0000-0724, 1979, pages 724-727.	
AB		TERZOPOULOS et al., "Analysis of Facial Images Using Physical and Anatomical Models", IEEE, CH2934-8/90/0000/072, 1990, pages 727-732.	
AB		DiPAOLA, "FaceSpace: a Facial Spatial-Domain Toolkit", IEEE, 1093-9547, pages 1-5.	
AB		DeCARLO et al., "An Anthropometric Face Model using Variational Techniques", Proceedings SIGGRAPH 1998, pages 67-74.	
AB		BLANZ et al., "Face Recognition Based on Fitting a 3D Morphable Model", IEEE, 0162-8828/03, 2003, pages 1063-1074.	
AB		ZHENG et al., "3D Models from Contours: Further Identification of Unexposed Areas", IEEE, 0-8186, 1992, pages 733-741.	

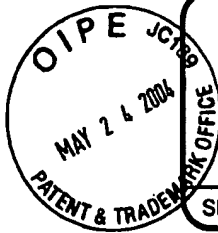
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<b>INFORMATION DISCLOSURE STATEMENT BY APPLICANT</b>  <i>(use as many sheets as necessary)</i>		<b>Application Number</b>	09/731,481
		<b>Filing Date</b>	12-06-2000
		<b>First Named Inventor</b>	Liu
		<b>Group Art Unit</b>	2623
		<b>Examiner Name</b>	Bhatnagar, A.
		<b>Attorney Docket Number</b>	MS1-684US
<b>Sheet</b>	3	<b>of</b>	3

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Examiner Initials <sup>1</sup>	Cite No. <sup>1</sup>	Include name of the author (in CAPITAL LETTERS), title of the article (when appropriate), title of the item (book, magazine, journal, serial, symposium, catalog, etc.), date, page(s), volume-issue number(s), publisher, city and/or country where published.	T <sup>2</sup>
AB		VETTER et al., "Linear Object Classes and Image Synthesis From a Single Example Image", IEEE Transactions on Pattern Analysis and Machine Intelligence vol. 19, n 7, 0162-8828/97, July 1997, pages 733-741.	
AB		DARIUSH et al., "Spatiotemporal Analysis of Face Profiles: Detection, Segmentation and Registration", IEEE, Inspec Accession Number 5920418, pages 248-253.	
AB		AKIMOTO et al., "Automatic Creation of 3D Facial Models", IEEE Computer Graphics & Applications, 0272-16/93, 1993, pages 16-22.	
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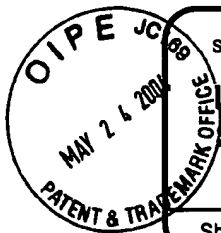
<b>Examiner Signature</b>	<i>Anand Bhatnagar</i>	<b>Date Considered</b>	12/5/04
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Sheet	1	of	3
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<b>Application Number</b>	09/731,481
<b>Filing Date</b>	12-06-2000
<b>First Named Inventor</b>	Liu
<b>Group Art Unit</b>	2623
<b>Examiner Name</b>	Bhatnagar, A.
<b>Attorney Docket Number</b>	MS1-684US

## U.S. PATENT DOCUMENTS

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